

Search Notes

Application/Control No.

10/824,798

Examiner

Rudy Zervigon

Applicant(s)/Patent under
Reexamination

SHINRIKI ET AL.

Art Unit

1763

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
118	715	6/10/2007	RZ
156	345.33	6/10/2007	RZ
156	345.34	6/10/2007	RZ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(ald OR "atomic layer distribution").clm. and (first and second and plate).clm.	6/10/2007	RZ